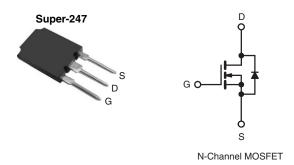
Vishay Siliconix

# **D Series Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	550				
R <sub>DS(on)</sub> max. at 25 °C (Ω)	V <sub>GS</sub> = 10 V	0.130			
Q <sub>g</sub> max. (nC)	125				
Q <sub>gs</sub> (nC)	23				
Q <sub>gd</sub> (nC)	37				
Configuration	Single				



#### **FEATURES**

- Optimal Design
  - Low Area specific On-Resistance
  - Low Input Capacitance (Ciss)
  - Reduced Capacitive Switching Losses
  - High Body Diode Ruggedness
  - Avalanche Energy Rated (UIS)
- · Optimal Efficiency and Operation
  - Low Cost
  - Simple Gate Drive Circuitry
  - Low Figure-Of-Merit (FOM): Ron x Qa
  - Fast Switching
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912

#### **APPLICATIONS**

- Consumer Electronics
  - Displays (LCD or Plasma TV
- Server and Telecom Power Supplies
  - SMPS
- Industrial
  - Welding, Induction Heating, Motor Drives
- · Battery Chargers

ORDERING INFORMATION				
Package	Super-247			
Lead (Pb)-free	SiHS36N50D-E3			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	500		
Gate-Source Voltage				± 30	V	
Gate-Source Voltage AC (f > 1 Hz)			$V_{GS}$	30		
Continuous Drain Current /T 150 °C\	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C		36		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	l <sub>D</sub>	23	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	112		
Linear Derating Factor				3.6	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	332	mJ	
Maximum Power Dissipation	$P_{D}$	446	W			
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Drain-Source Voltage Slope	in-Source Voltage Slope T <sub>J</sub> = 125 °C		dV/dt	24	V/ns	
Reverse Diode dV/dt <sup>d</sup>			uv/ul	0.1	7 V/ris	
Soldering Recommendations (Peak Temperature) for 10 s				300°	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=50~V$ , starting  $T_J=25~^{\circ}C$ , L=2.3~mH,  $R_g=25~\Omega$ ,  $I_{AS}=17~A$ .
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , starting  $T_J = 25$  °C.



# Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.28	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 250 μA	-	0.52	-	V/°C
Gate Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
-		V <sub>DS</sub> =	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 18 A	-	0.105	0.130	Ω
Forward Transconductancea	9 <sub>fs</sub>		= 50 V, I <sub>D</sub> = 18 A	-	12.8	_	S
Dynamic						l	
Input Capacitance	C <sub>iss</sub>	T	V <sub>GS</sub> = 0 V,	-	3233	_	
Output Capacitance	C <sub>oss</sub>	1	$V_{DS} = 100 \text{ V},$	-	285	-	-
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		-	25	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 V to 400 V		-	240	-	pF
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	352	-	1
Total Gate Charge	Qg			-	83	125	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	23	-	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	37	-	
Turn-On Delay Time	t <sub>d(on)</sub>			-	33	66	
Rise Time	t <sub>r</sub>	$V_{DD} = 400 \text{ V}, I_{D} = 18 \text{ A}, V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		1	89	134	ns
Turn-Off Delay Time	$t_{d(off)}$			-	79	119	
Fall Time	t <sub>f</sub>			-	68	102	
Gate Input Resistance	$R_g$	f = 1 MHz, open drain		-	1.8	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	36	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	144	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 18 A, V <sub>GS</sub> = 0 V		-	-	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	0 1 17 0 1 7 00 1		-	490	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>		5 °C, I <sub>F</sub> = I <sub>S</sub> = 18 A,	-	8.2	-	μC
Reverse Recovery Current	I <sub>RRM</sub>	dl/dt = 100 A/μs, V <sub>R</sub> = 20 V		_	31	_	A

## **Notes**

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

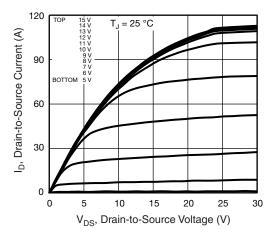


Fig. 1 - Typical Output Characteristics

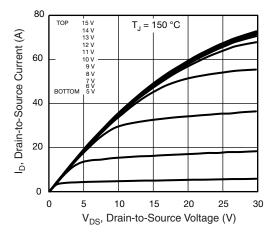


Fig. 2 - Typical Output Characteristics

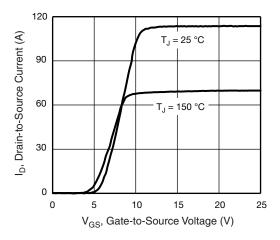


Fig. 3 - Typical Transfer Characteristics

S12-1457-Rev. A, 18-Jun-12

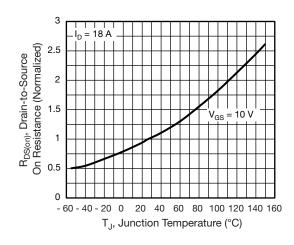


Fig. 4 - Normalized On-Resistance vs. Temperature

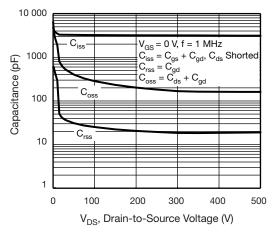


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

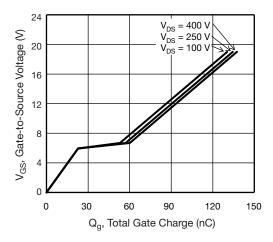


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



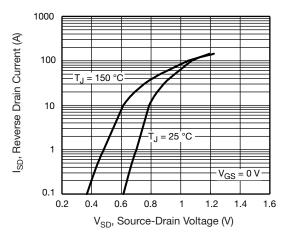


Fig. 7 - Typical Source-Drain Diode Forward Voltage

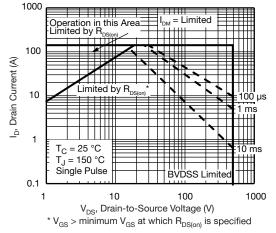


Fig. 8 - Maximum Safe Operating Area

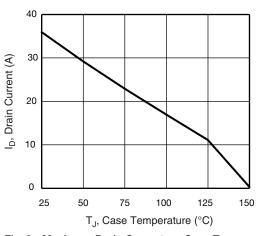


Fig. 9 - Maximum Drain Current vs. Case Temperature

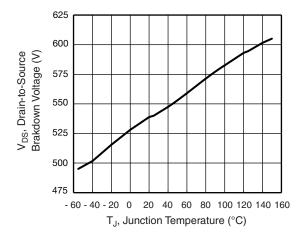


Fig. 10 - Temperature vs. Drain-to-Source Voltage

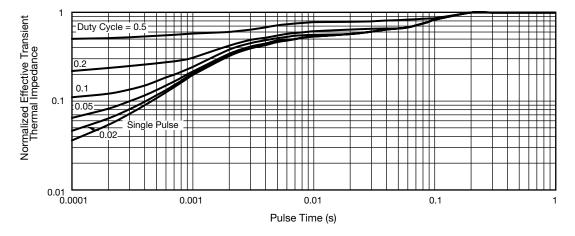


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



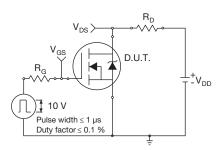


Fig. 12 - Switching Time Test Circuit

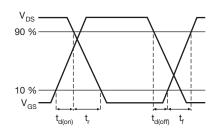


Fig. 13 - Switching Time Waveforms

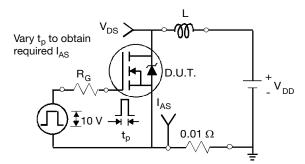


Fig. 14 - Unclamped Inductive Test Circuit

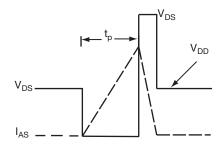


Fig. 15 - Unclamped Inductive Waveforms

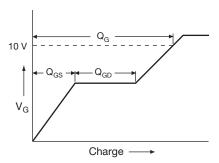


Fig. 16 - Basic Gate Charge Waveform

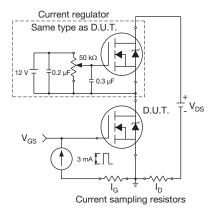
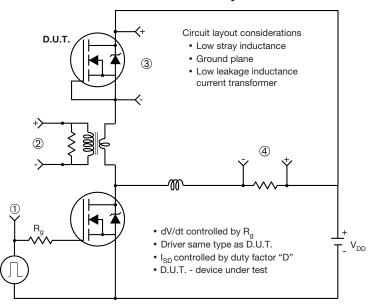


Fig. 17 - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



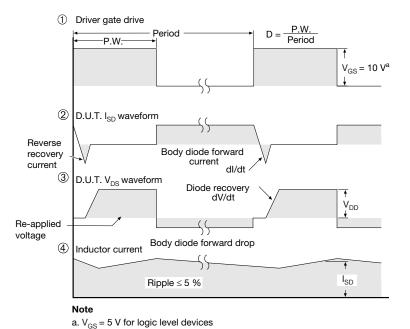
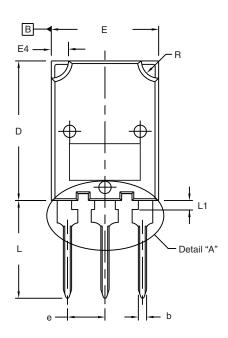


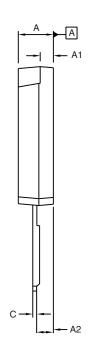
Fig. 18 - For N-Channel

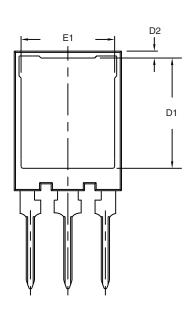
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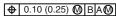
Vishay Siliconix

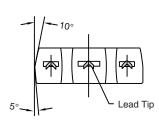
# **TO-274AA (High Voltage)**

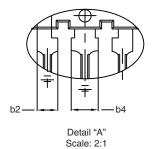












	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
c <sup>(1)</sup>	0.38	0.89	0.015	0.035
D	19.80	20.80	0.780	0.819

	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	15.50	16.10	0.610	0.634
D2	0.70	1.30	0.028	0.051
Е	15.10	16.10	0.594	0.634
E1	13.30	13.90	0.524	0.547
е	5.45 BSC		0.215 BSC	
L	13.70	14.70	0.539	0.579
L1	1.00	1.60	0.039	0.063
R	2.00	3.00	0.079	0.118

ECN: X17-0056-Rev. B, 27-Mar-17

DWG: 5975

#### Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body
- Outline conforms to JEDEC® outline to TO-274AA
- (1) Dimension measured at tip of lead



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Vishay

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